

### Product Description

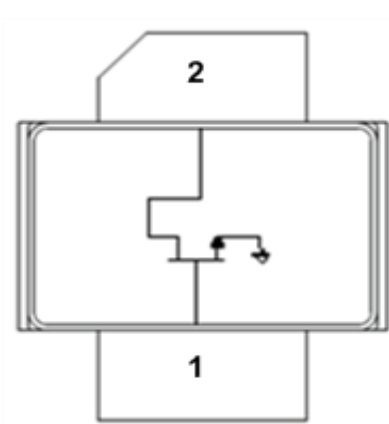
The QPD2195 is a discrete GaN on SiC HEMT which operates from 1.8-2.2 GHz. The device is a single stage pre-matched power amplifier transistor.

The QPD2195 can be used in Doherty architecture for the final stage of a base station power amplifier for macrocell high efficiency systems.

QPD2195 can deliver  $P_{3dB}$  of 400 W at +48 V operation.

Lead-free and ROHS compliant.

### Functional Block Diagram



2 Lead NI780 Package

### Product Features<sup>1</sup>

- Operating Frequency Range: 1.8-2.2 GHz
- Operating Drain Voltage: +48 V
- Maximum Output Power<sup>1</sup> ( $P_{3dB}$ ): 400 W
- Maximum Drain Efficiency<sup>1</sup>: 75.4%
- Efficiency-Tuned P3dB Gain<sup>1</sup>: 19.1 dB
- 2-lead, earless, ceramic flange NI780 package

Note 1: @ 2.11 GHz Load Pull

### Applications

- W-CDMA / LTE
- Macrocell Base Station, B3-B1
- Active Antenna

### Ordering Information

Part No.	ECCN	Description
QPD2195S2	EAR99	Box (2 Samples Each)
QPD2195SQ	EAR99	Tray (25 Samples)
QPD2195SR	EAR99	Reel (100 Samples)
QPD2195PCB4B01	EAR99	1.805-2.170 GHz Eval. Board



# QPD2195

## 400 W, 48 V, 1.8-2.2 GHz GaN RF Power Transistor

### Absolute Maximum Ratings

Parameter	Value / Range
Gate Current ( $I_G$ )	-67 to 67 mA
Drain Voltage ( $V_D$ )	+55 V
Peak RF Input Power	44 dBm
VSWR Mismatch, P1dB Pulse (10 % duty cycle, 100 $\mu$ width), T = 25 °C	10:1
Storage Temperature	-65 to +150°C

Operation of this device outside the parameter ranges given above may cause permanent damage.

### Recommended Operating

Parameter	Min	Typ	Max	Units
Operating Temperature	-40	-	-	°C
Gate Voltage ( $V_G$ )	-	-2.8	-	V
Drain Voltage ( $V_D$ )	-	48	-	V
Quiescent Current ( $I_{DQ}$ )	-	720	-	mA
$T_{CH}$ for >10 <sup>6</sup> hours MTTF	-	-	250	°C

Electrical performance is measured under conditions noted in the electrical specifications table. Specifications are not guaranteed over all recommended operating conditions.

### RF Characterization

Parameter	Conditions	Min	Typ	Max	Units
Frequency Range		1805	-	2170	MHz
Quiescent Current		-	720	-	mA
Linear Gain		-	20.4	-	dB
P3dB		-	56.3	-	dBm
Drain Efficiency	P3dB	-	70.1	-	%

Test conditions unless otherwise noted:  $V_D = +48$  V,  $I_{DQ} = 720$  mA, T = 25°C, Pulsed CW (10% duty cycle, 100  $\mu$ s width) on Class AB single-ended EVB at 1880 MHz

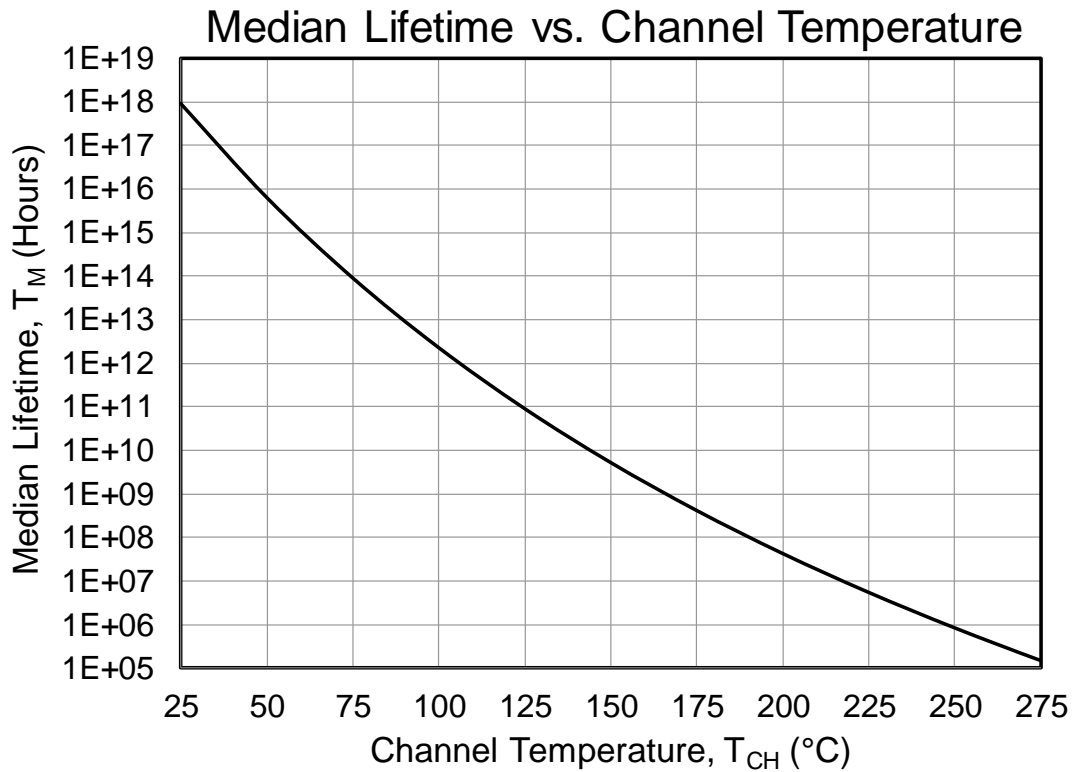
### Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Carrier Amplifier Thermal Resistance at Average Power ( $\theta_{JC}$ )	$T_{CASE} = 85^{\circ}C$ , $T_{CH} = 121^{\circ}C$ , CW: $P_{DISS} = 60 W$ , $P_{OUT} = 90 W$	0.6	$^{\circ}C/W$

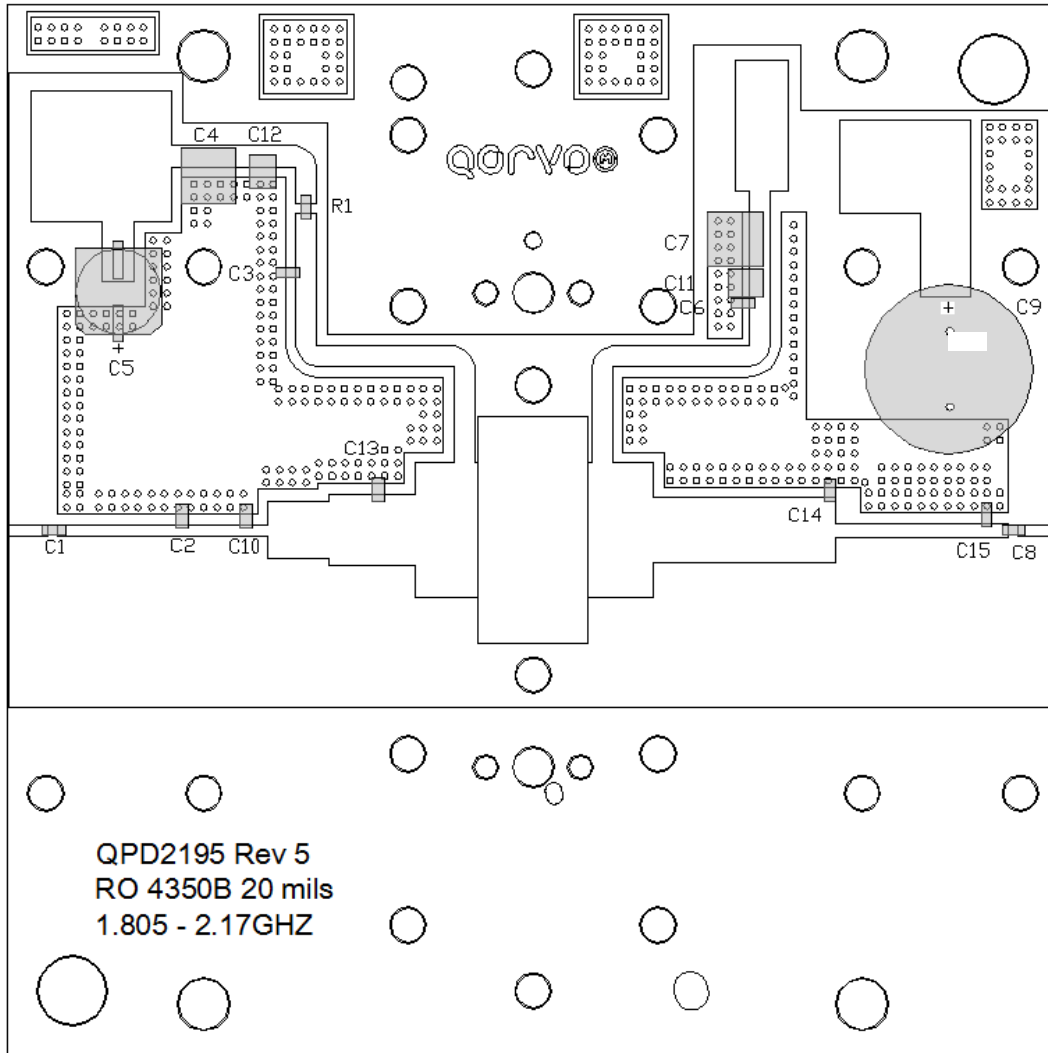
Notes:

1. Thermal resistance measured to package backside.
2. Based on expected carrier amplifier efficiency of Doherty.
3.  $P_{OUT}$  assumes 20% peaking amplifier contribution of total average Doherty rated power.

### Median Lifetime



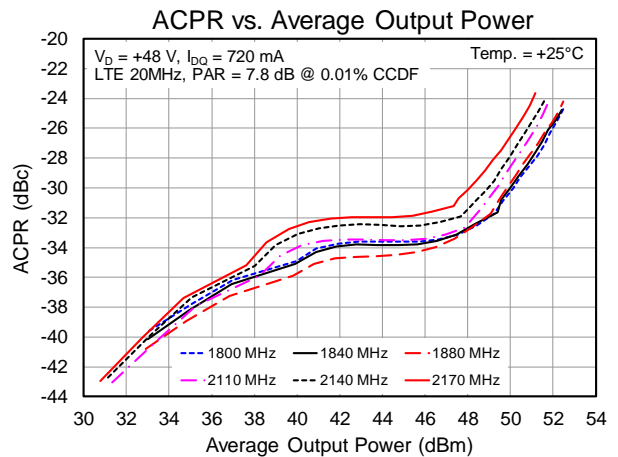
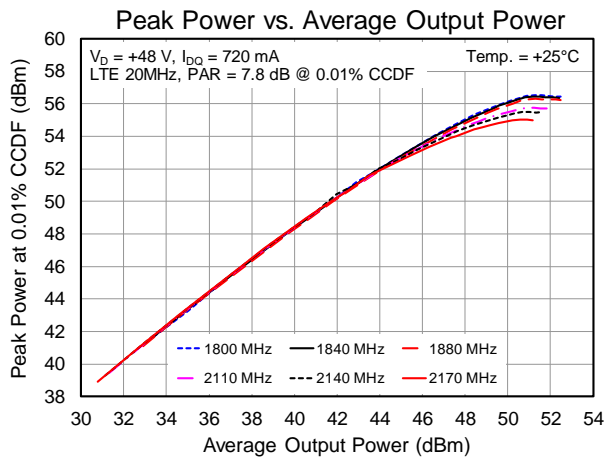
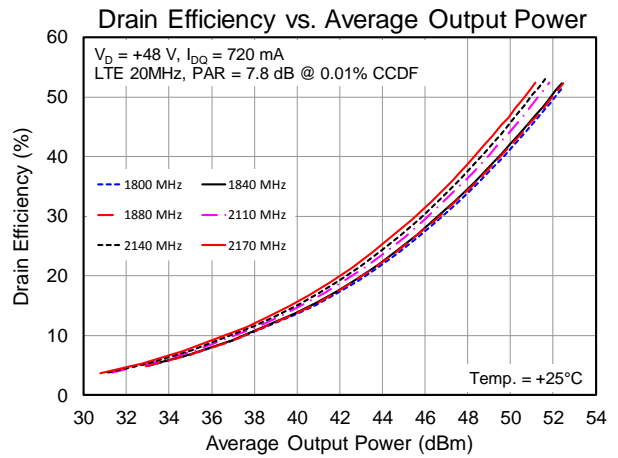
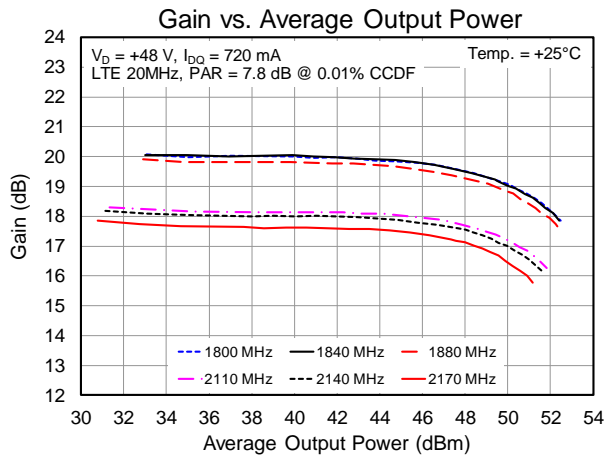
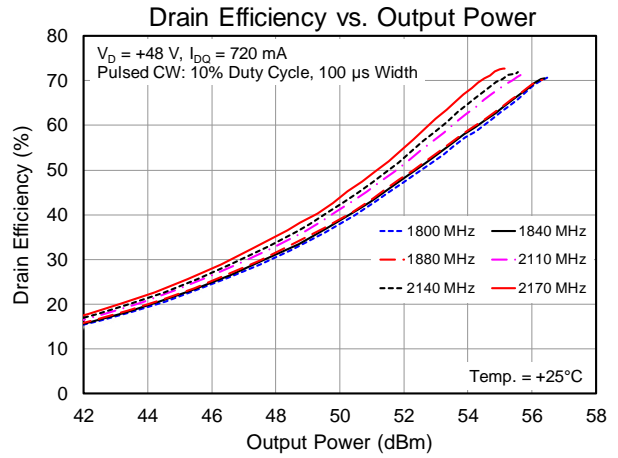
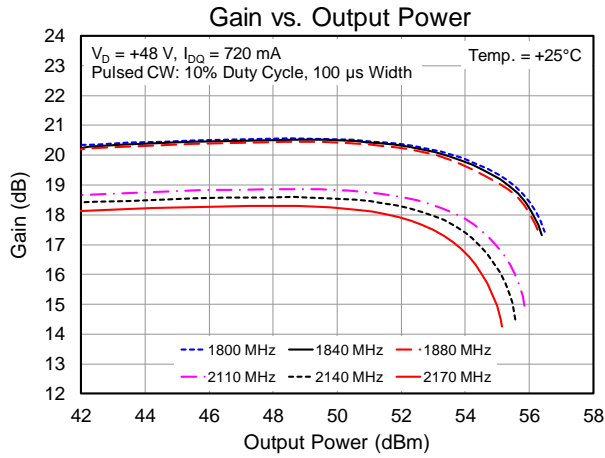
**Single-Ended Evaluation Board Layout**



**Bill of Materials**

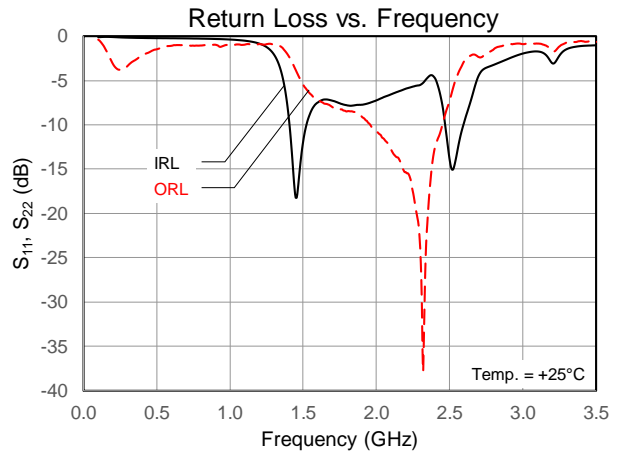
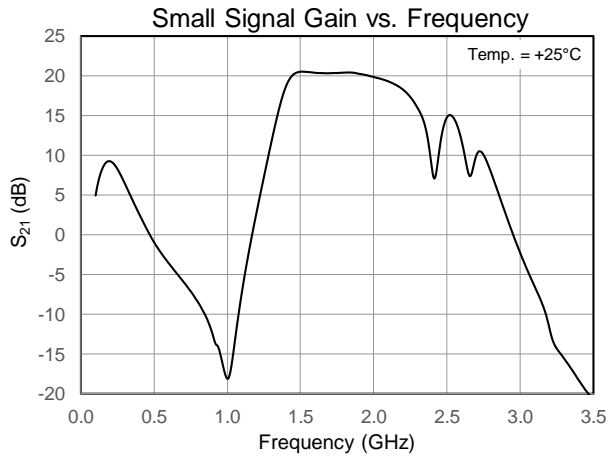
Reference Des.	Value	Description	Manuf.	Part Number
C1, C3, C6, C8	33 pF	Capacitor, 33 pF, 5%, 250V	ATC	ATC800A330JT250X
C2	0.6 pF	Capacitor, 0.6 pF, +/- 0.1pF, 250V	ATC	ATC800A0R6BT250X
C10	0.2 pF	Capacitor, 0.2 pF, +/- 0.1pF, 250V	ATC	ATC800A0R2BT250X
C14, C15	0.4 pF	Capacitor, 0.4 pF, +/- 0.1pF, 250V	ATC	ATC800A0R4BT250X
C13	0.3 pF	Capacitor, 0.3 pF, +/- 0.1pF, 250V	ATC	ATC800A0R3BT250X
C11, C12	1.0 $\mu$ F	Capacitor, 1 $\mu$ F, 10%, 100V, X7R	MURATA	GRM32NR72A104KA01L
C4, C7	4.7 $\mu$ F	Capacitor, 4.7 $\mu$ F, 10%, 100V, X7R	MURATA	GRM55ER72A475KA01L
C5	100 $\mu$ F	Capacitor, 100uF, 50V, +/-20%, SMD	Panasonic	EEE-1HA101UAP
C9	220 $\mu$ F	Capacitor, 220uF, 100V, +/-20%, SMD	Panasonic	AFK227M2AR44T-F
R1	10 $\Omega$	Resistor, 10 $\Omega$ , 5%, 0.25W, 1206	Panasonic	ERJ-8ENF10R0V

### Single-Ended Evaluation Board Performance Plots



Test conditions unless otherwise noted:  $V_D = +48\text{ V}$ ,  $I_{DQ} = 720\text{ mA}$ ,  $T = 25^\circ\text{C}$ , on Class AB single-ended EVB

**Single-Ended Evaluation Board Performance Plots**



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### RF Characterization – Power-Tuned Load Pull Performance

Frequency (MHz)	Source Impedance	Load Impedance	Gain @ P3dB (dB)	P3dB (dBm)	Drain Efficiency (%)
1800	1.68 – j2.21	5.39 – j1.33	18.2	56.0	60.5
1840	1.34 – j2.45	5.39 – j1.33	18.1	56.1	62.7
1880	1.44 - j2.82	5.54 - j0.11	17.8	56.2	60.9
1990	1.51 – j3.72	5.79 + j1.48	17.4	56.0	60.4
2110	2.00 – j5.57	3.89 + j3.09	17.2	56.0	60.5
2140	2.48 – j6.14	3.67 + j3.42	16.7	56.0	59.5
2170	3.07 - j6.71	3.67 + j3.42	16.6	56.1	61.8
2200	3.38 – j7.21	3.11 + j3.04	16.6	55.9	58.5

Test conditions unless otherwise noted:  $V_D = +48$  V,  $I_{DQ} = 720$  mA,  $T = 25^\circ\text{C}$ , Pulsed (10% duty cycle, 100  $\mu\text{s}$  width)

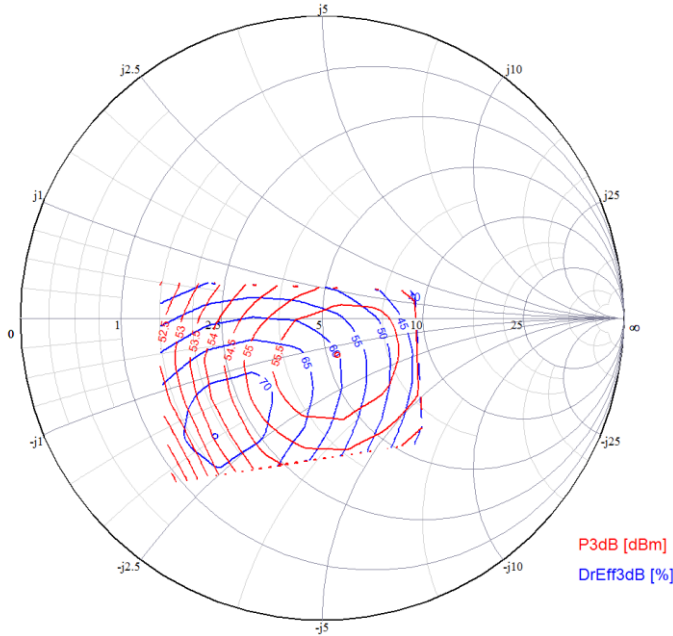
### RF Characterization – Efficiency-Tuned Load Pull Performance

Frequency (MHz)	Source Impedance	Load Impedance	Gain @ P3dB (dB)	P3dB (dBm)	Drain Efficiency (%)
1800	1.68 – j2.21	1.79 – j1.97	20.3	53.5	72.6
1840	1.34 – j2.45	1.79 – j1.97	20.2	53.2	73.3
1880	1.44 - j2.82	1.79 - j1.97	19.9	53.1	73.9
1990	1.51 – j3.72	3.10 – j1.88	19.4	53.9	74.1
2110	2.00 – j5.57	4.36 – j2.15	19.1	53.2	75.4
2140	2.48 – j6.14	4.40 – j2.03	18.8	53.0	75.5
2170	3.07 - j6.71	5.70 - j2.55	18.4	53.0	77.4
2200	3.38 – j7.21	6.74 – j1.27	18.4	53.6	75.5

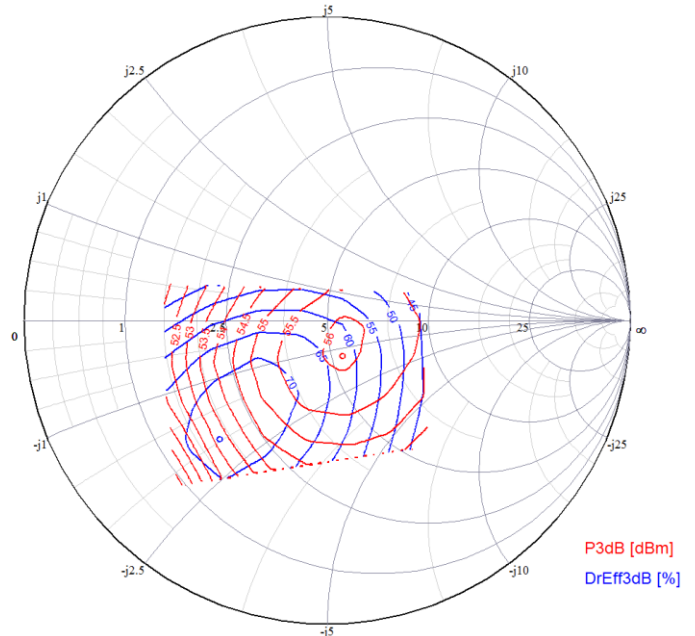
Test conditions unless otherwise noted:  $V_D = +48$  V,  $I_{DQ} = 720$  mA,  $T = 25^\circ\text{C}$ , Pulsed (10% duty cycle, 100  $\mu\text{s}$  width)

### Load Pull Plots

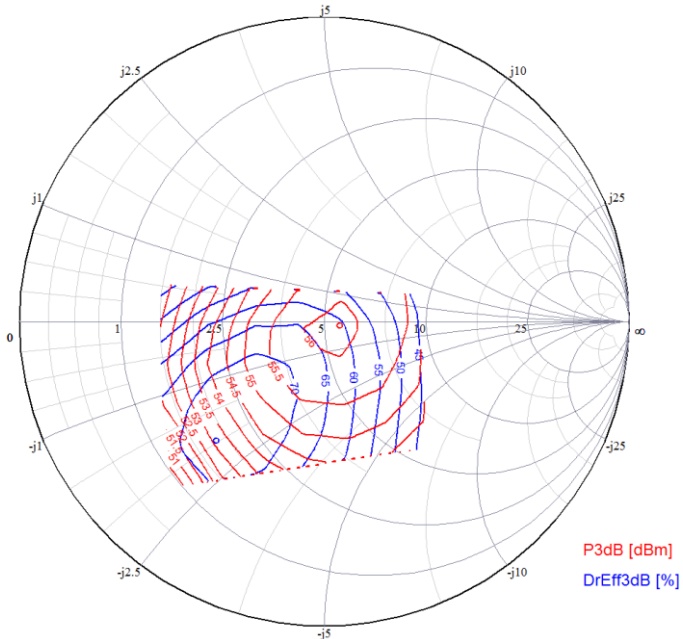
Load Pull at 1.8 GHz



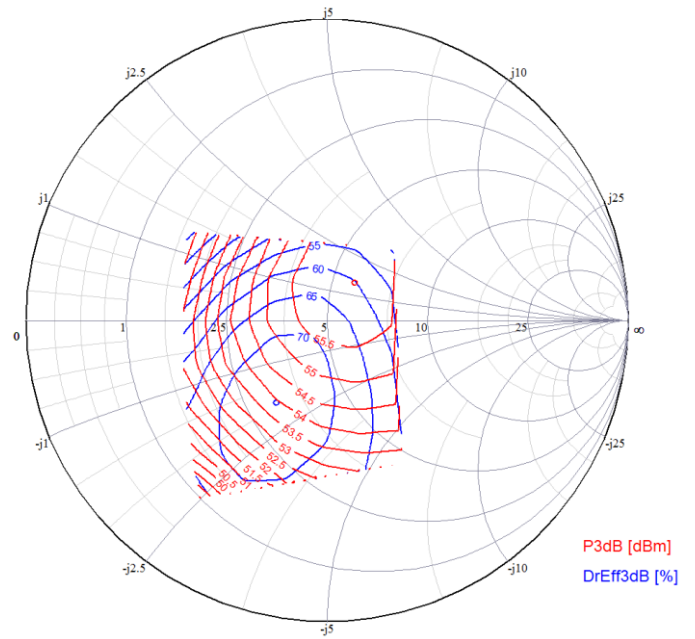
Load Pull at 1.84 GHz



Load Pull at 1.88 GHz



Load Pull at 1.99 GHz

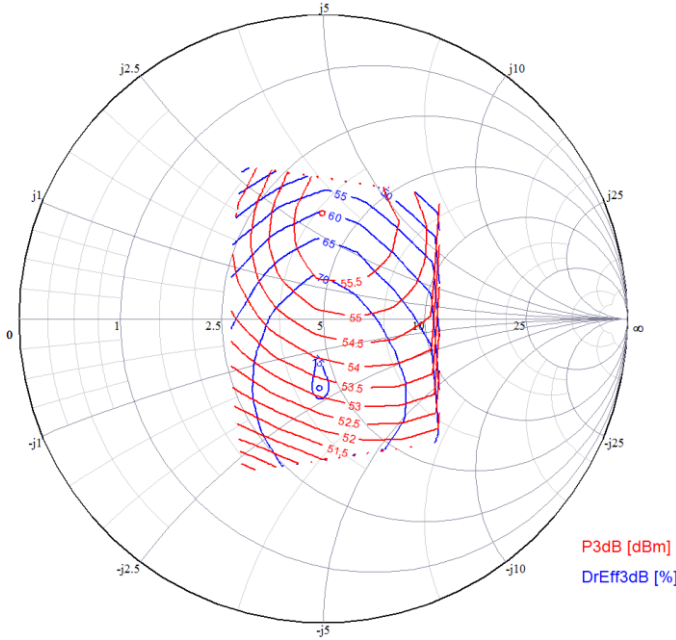


Test conditions unless otherwise noted:  $V_D = +48$  V,  $I_{DQ} = 720$  mA,  $T = 25^\circ\text{C}$ , Pulsed (10% duty cycle, 100  $\mu\text{s}$  width)

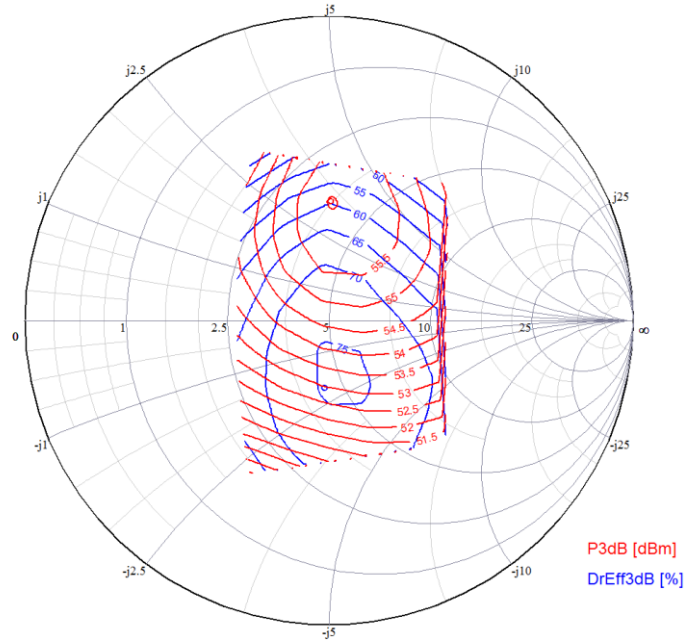


**Load Pull Plots**

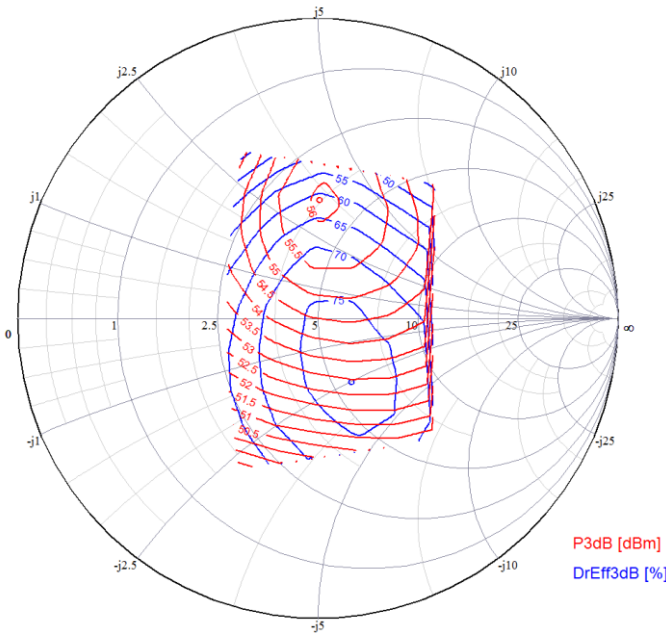
Load Pull at 2.11 GHz



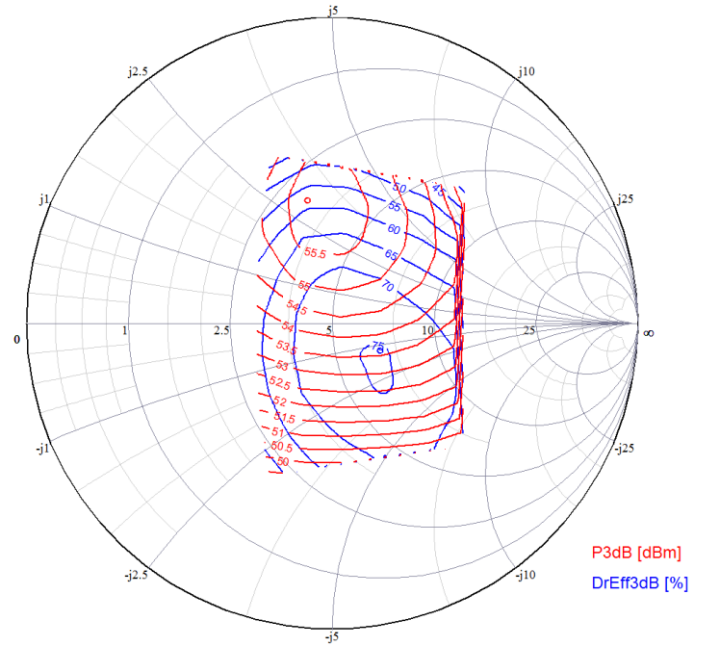
Load Pull at 2.14 GHz



Load Pull at 2.17 GHz

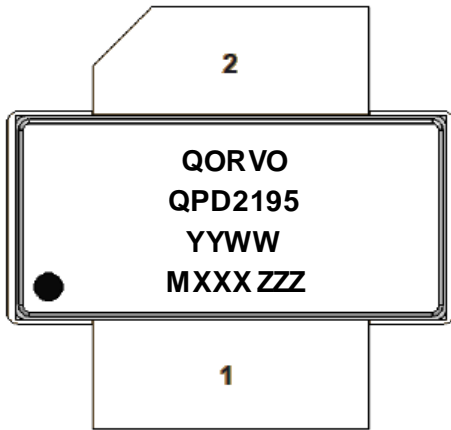


Load Pull at 2.2 GHz

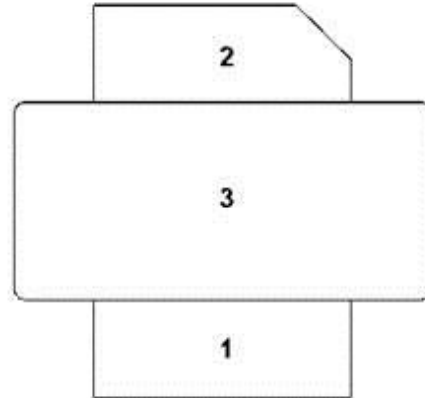


Test conditions unless otherwise noted:  $V_D = +48\text{ V}$ ,  $I_{DQ} = 720\text{ mA}$ ,  $T = 25^\circ\text{C}$ , Pulsed (10% duty cycle, 100  $\mu\text{s}$  width)

## Pin Configuration



TOP VIEW



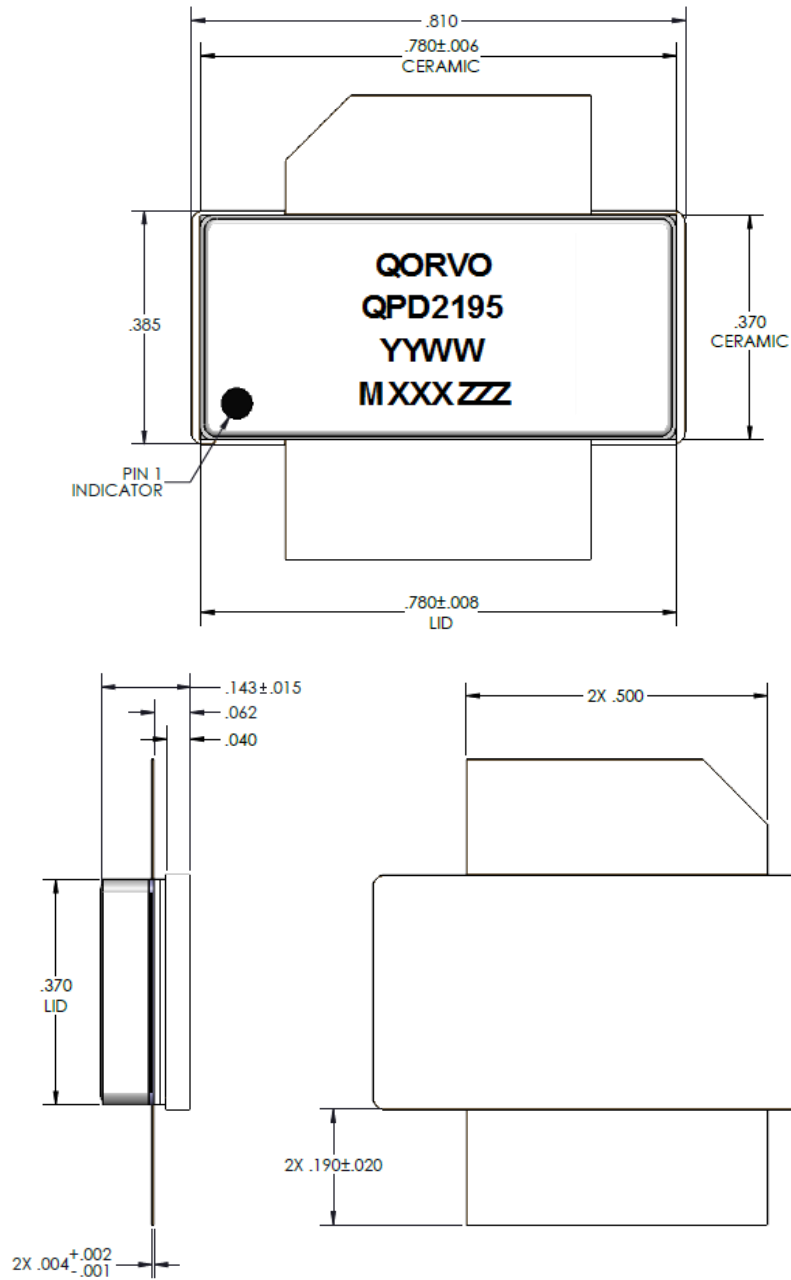
BOTTOM VIEW

## Pin Description

Pin No.	Label	Description
1	RF IN, VG	RF Input, Gate Bias
2	RF OUT, VD	RF Output, Drain Bias
3 (Backside Paddle)	RF/DC GND	RF/DC Ground

## Package Marking and Dimensions

Marking: Qorvo Logo  
 Part Number and Package Version – QPD2195  
 Date Code – YYWW  
 Production Lot Number – MXXX  
 Serial Number – ZZZ



**Notes:**

1. All dimensions are in inches. Angles are in degrees.
2. Exposed metallization is NiAu plated.